

<IGBT Modules>

CM1000DX-24T/CM1000DXP-24T

HIGH POWER SWITCHING USE **INSULATED TYPE**

	the should be	Collector current I _c 1 0 0 0 A				
		Collector-emitter voltage V _{CES} 1 2 0 0 V				
	•	Maximum junction temperature Tvjmax 175°C				
DX		●Flat base type				
		 Copper base plate (Nickel-plating) 				
		 RoHS Directive compliant 				
		 Tin-plating pin terminals 				
		Collector current Ic 1000A				
		Collector-emitter voltage Vces 1 2 0 0 V				
	-	Maximum junction temperature T _{vjmax} 175 °C				
DXP		●Flat base type				
		 Copper base plate (Nickel-plating) 				
		 RoHS Directive compliant 				
		 Tin-plating pressfit terminals 				
	dual switch (half-bridge)	•UL Recognized under UL1557, File No. E323585				

APPLICATION

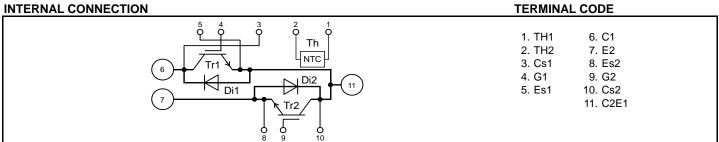
AC Motor Control, Motion/Servo Control, Power supply, etc.

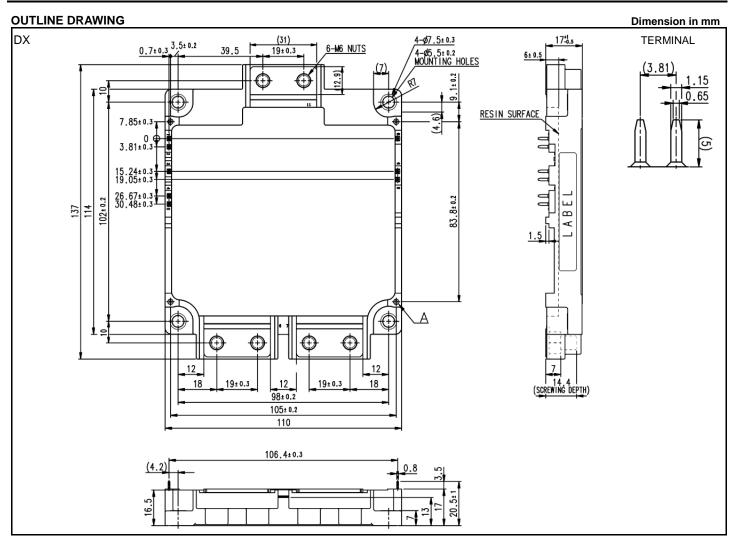
OPTION (Below options are available.)

•PC-TIM (Phase Change Thermal Interface Material) pre-apply

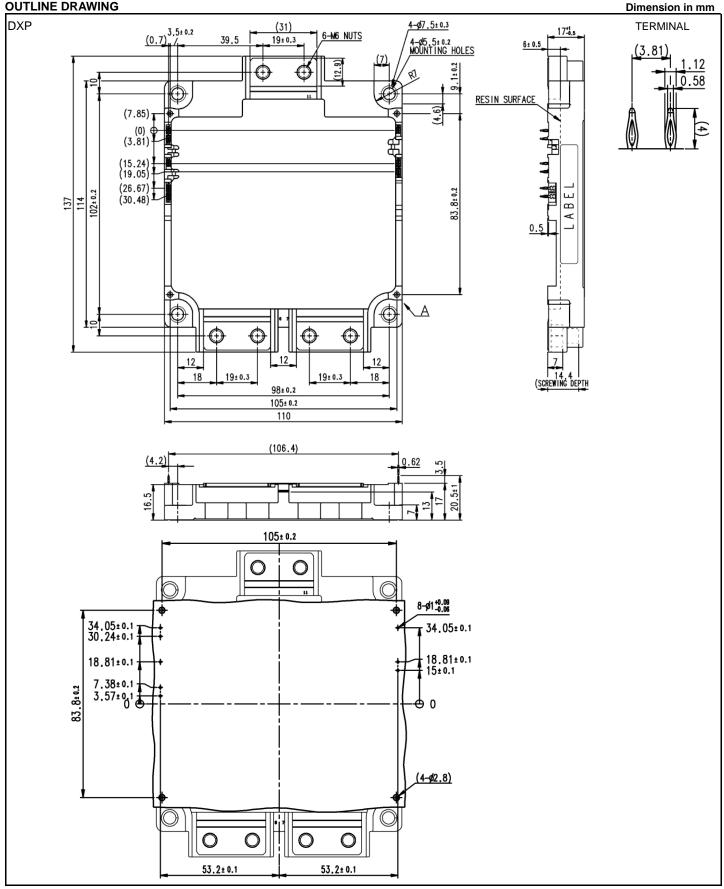
•V_{CEsat} selection for parallel connection

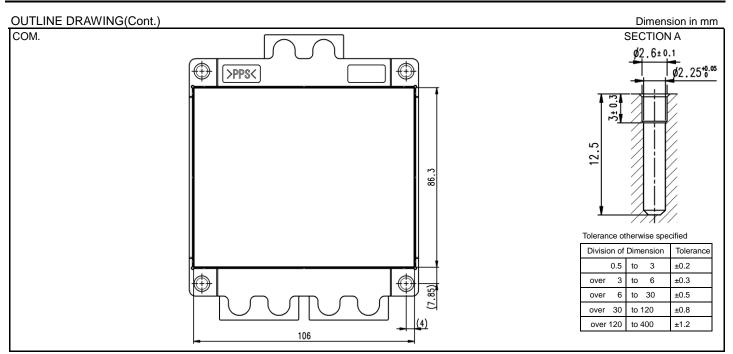
INTERNAL CONNECTION











MAXIMUM RATINGS (T $_{vj}$ =25 °C, unless otherwise specified) INVERTER PART IGBT/FWD

Symbol	Item	Conditions	Rating	Unit	
V _{CES}	Collector-emitter voltage	G-E short-circuited	1200	V	
V _{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V	
I _C	Collector current	DC, T _C =116 °C (Note2, 4)	1000	A	
I _{CRM}		Pulse, Repetitive (Note3)	2000		
P _{tot}	Total power dissipation T _C =25 °C (Note2, 4)		5355	W	
IE (Note1)	Emitter current	DC (Note2)	1000	^	
IERM (Note1)	Emitter current	Pulse, Repetitive (Note3)	2000	A	

MODULE

MODULE				
Symbol	Item	Conditions	Rating	Unit
Visol	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	2500	V
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload)	175	°C
T _{Cmax}	Maximum case temperature	(Note4)	125	
T _{vjop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	°C
T _{stg}	Storage temperature	-	-40 ~ +125	C

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified) INVERTER PART IGBT/FWD

Symbol	ltem	Conditions			Limits		Unit
Symbol	nem	Conditions		Min.	Тур.	Max.	Unit
I _{CES}	Collector-emitter cut-off current	$V_{CE}=V_{CES}$, G-E short-circuited		-	-	1.0	mA
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited		-	-	0.5	μA
$V_{\text{GE(th)}}$	Gate-emitter threshold voltage	I _C =100 mA, V _{CE} =10 V	I _C =100 mA, V _{CE} =10 V		6.0	6.6	V
		I _C =1000 A, V _{GE} =15 V,	T _{vj} =25 °C	-	1.55	1.95	
V _{CEsat}		Refer to the figure of test circuit	T _{vj} =125 °C	-	1.70	-	V
(Terminal)		(Note5)	T _{vj} =150 °C	-	1.75	-	1
	Collector-emitter saturation voltage	I _C =1000 A,	T _{vj} =25 °C	-	1.50	1.75	
V _{CEsat}		V _{GE} =15 V,	T _{vj} =125 °C	-	1.70	-	V
(Chip)		(Note5)	T _{vj} =150 °C	-	1.75	-	1
Cies	Input capacitance			-	-	242.5	
C _{oes}	Output capacitance	V _{CE} =10 V, G-E short-circuited		-	-	6.8	nF
Cres	Reverse transfer capacitance			-	-	3.0	
Q _G	Gate charge	V _{CC} =600 V, I _C =1000 A, V _{GE} =15 V		-	7.5	-	μC
t _{d(on)}	Turn-on delay time	V_{cc} =600 V, I _c =1000 A, V_{GE} =±15 V, R _G =2.0 Ω, Inductive load		-	-	800	- ns
tr	Rise time			-	-	400	
t _{d(off)}	Turn-off delay time			-	-	1300	
t _f	Fall time			-	-	400	
		I _E =1000 A, G-E short-circuited,	T _{vi} =25 °C	-	1.65	2.15	
V _{EC} ^(Note1)		Refer to the figure of test circuit	T _{vi} =125 °C	-	1.75	-	v
(Terminal)		(Note5)	T _{vi} =150 °C	-	1.80	-	1
	Emitter-collector voltage	I _E =1000 A,	T _{vi} =25 °C	-	1.60	1.95	
V _{EC} ^(Note1)		G-E short-circuited,	T _{vi} =125 °C	-	1.60	-	v
(Chip)		(Note5)	T _{vi} =150 °C	-	1.60	-	1
t _{rr} (Note1)	Reverse recovery time	V _{CC} =600 V, I _E =1000 A, V _{GE} =±15 V,	,	-	-	500	ns
Qrr (Note1)	Reverse recovery charge	$R_{G}=2.0 \Omega$, Inductive load		-	78	-	μC
Eon	Turn-on switching energy per pulse	V _{cc} =600 V, I _c =I _E =1000 A,		-	150.5	-	
E _{off}	Turn-off switching energy per pulse	$V_{GE}=\pm 15 \text{ V}, \text{ R}_{G}=2.0 \Omega, \text{ T}_{vj}=150 \text{ °C},$		-	128.4	-	mJ
Err (Note1)	Reverse recovery energy per pulse	Inductive load		-	69	-	mJ
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, per switch, Tc=25 °C (Note4)		-	0.5	-	mΩ
r _g	Internal gate resistance	Per switch		-	0.4	-	Ω
		L		L	1	1	<u>. </u>
					Limits		
Symbol	Item	Conditions		Min.	Тур.	Max.	Unit

Symbol Item		Conditions				Unit
Symbol	nem	Conditions	Min.	Тур.	Max.	Onit
R ₂₅	Zero-power resistance	T _C =25 °C (Note4)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R ₁₀₀ =493 Ω, T _C =100 °C (Note4)	-7.3	-	+7.8	%
B _(25/50)	B-constant	Approximate by equation (Note6)	-	3375	-	К
P ₂₅	Power dissipation	T _C =25 °C (Note4)	-	-	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symphol	ltom	Conditions			Unit			
Symbol Item		Conditions		Min.	Тур.	Max.	Unit	
R _{th(j-c)Q}	Thermal resistance	Junction to case, per Inverter IGBT (Note4)		-	-	28	K/kW	
R _{th(j-c)D}	mermanesistance		-	-	49	rv/kvv		
Р	Contact thermal registered	Case to heat sink, Thermal grease applied (N	ote4, 7)	-	7.1	-	K/kW	
R _{th(c-s)}	Contact thermal resistance	per 1 module, PC-TIM applied (Note4, 8)		-	1.9	-	r/kvv	

MECHANICAL CHARACTERISTICS

Currente e l	lán m	0.00	Conditions		Limits			
Symbol	Item	Cor			Тур.	Max.	Unit	
M _t	Mounting torque	Main terminals	Main terminals M 6 screw		4.0	4.5	N∙m	
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N∙m	
ds			Terminal to terminal	17.3	-	-	mm	
	Creepage distance	Solder pin type (DX)	Terminal to base plate	17.5	-	-		
			Terminal to terminal	16.5	-	-	mm	
		Pressfit pin type (DXP)	Terminal to base plate	18.0	-	-		
	Clearance		Terminal to terminal	10.3	-	-	mm	
d		Solder pin type (DX)	Terminal to base plate	11.7	-	-		
da			Terminal to terminal	10.2	-	-		
		Pressfit pin type (DXP)	Pressfit pin type (DXP) Terminal to base plate		-	-	mm	
ec	Flatness of base plate	On the centerline X, Y	On the centerline X, Y (Note9)		-	+200	μm	
m	mass	-	-		490	-	g	

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

2. Junction temperature (T $_{\nu j}$) should not increase beyond T $_{\nu j\,m\,a\,x}$ rating.

3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed T_{vjmax} rating.

4. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

6. $B_{(25/50)} = ln(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} - \frac{1}{T_{50}})$

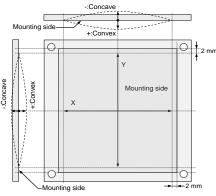
 $R_{25}\!\!:$ resistance at absolute temperature T_{25} [K]; $T_{25}\!\!=\!\!25$ [°C]+273.15=298.15 [K]

 R_{50} : resistance at absolute temperature T_{50} [K]; $T_{50}{=}50$ [°C]+273.15=323.15 [K]

7. Typical value is measured by using thermally conductive grease of $\lambda=0.9$ W/(m·K)/D_(C-S)=50 $\mu m.$

8. Typical value is measured by using PC-TIM of $\lambda{=}3.4$ W/(m·K)/D_(C-S)=50 $\mu m.$

9. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



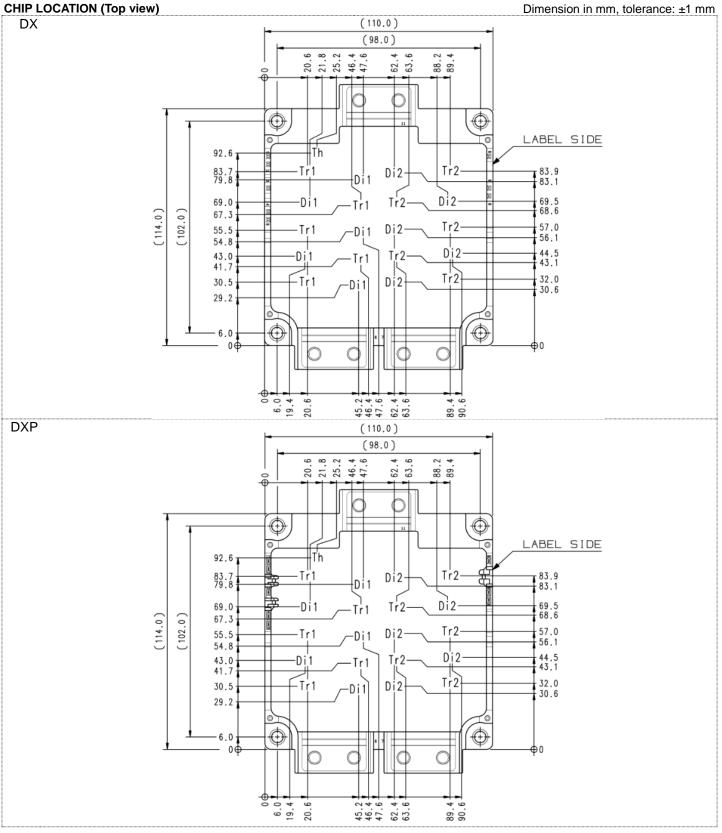
10. Use the following screws when mounting the printed circuit board (PCB) on the standoffs. PCB thickness : t1.6

	Туре	Manufacturer	Size	Tightening torque (N•m)	Recommended tightening method
(1)	PT®	EJOT	K25×8	0.55 ± 0.055	
(2)	PT®	-	K25×10	0.75 ± 0.075 N∙m	by handwork (equivalent to 30 rpm
(3)	DELTA PT®	-	25×8	0.55 ± 0.055 N∙m	by mechanical screw driver)
(4)	DELTA PT®	-	25×10	0.75 ± 0.075 N∙m	~ 600 rpm (by mechanical screw driver)
(5)	B1	-	φ2.6×10	0.75 ± 0.075 N ⋅ m	
	tapping screw		φ2.6×12	0.75 ± 0.075 N-III	

RECOMMENDED OPERATING CONDITIONS

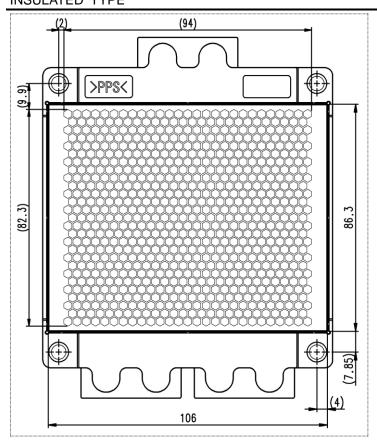
Symbol	Item	Conditions		Unit		
	nem	Conditions	Min.	Тур.	Max.	Offic
V _{cc}	(DC) Supply voltage	Applied across C1-E2 terminals		600	850	V
V _{GEon}	Gate (-emitter drive) voltage	Applied across G1-E1s/G2-E2s terminals	13.5	15.0	16.5	V
R _G	External gate resistance	Per switch	2.0	-	20	Ω

MITSUBISHI ELECTRIC CORPORATION

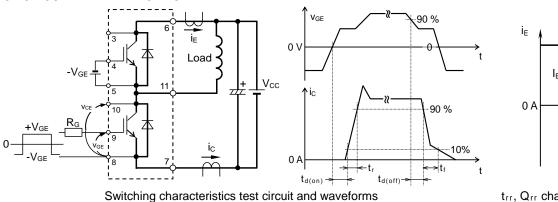


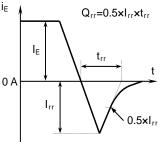
Tr1/Tr2: IGBT, Di1/Di2: FWD, Th: NTC thermistor

Option: PC-TIM applied baseplate outline



TEST CIRCUIT AND WAVEFORMS

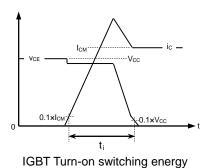


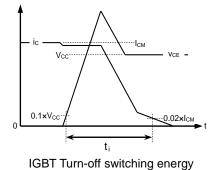


trr, Qrr characteristics test waveform

ti

VEC





FWD Reverse recovery energy

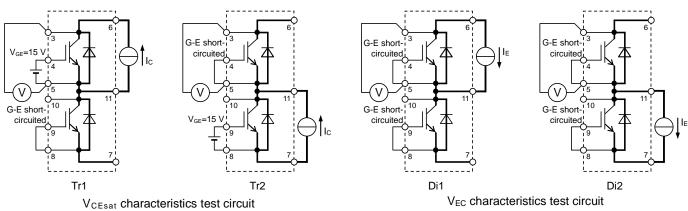
IEM

0 A

0 ۷

Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

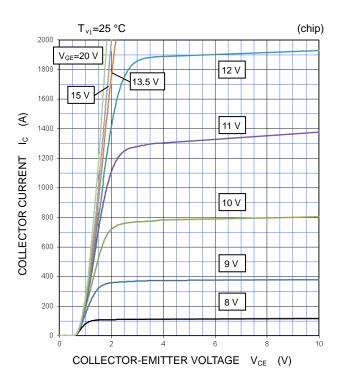
TEST CIRCUIT



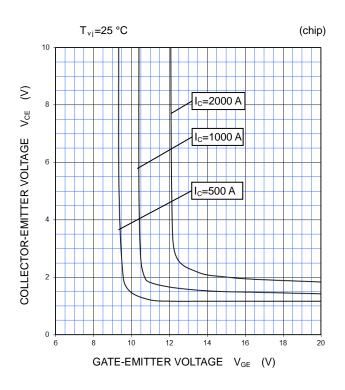
PERFORMANCE CURVES

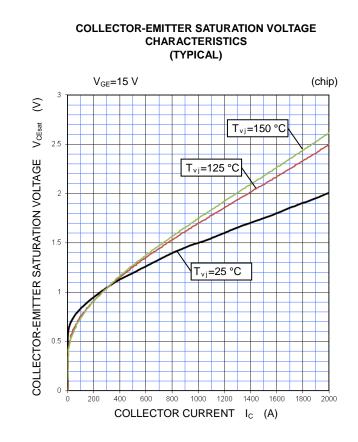
INVERTER PART



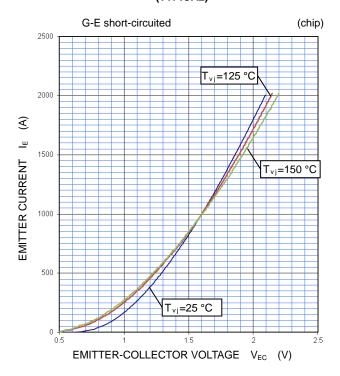


COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)





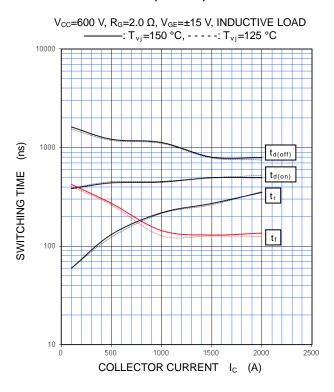
FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



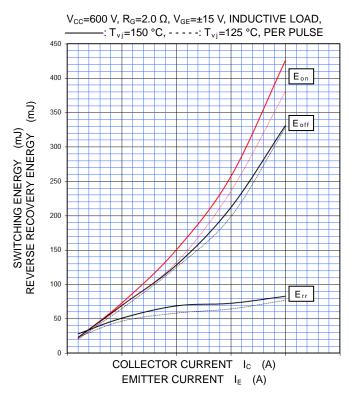
PERFORMANCE CURVES

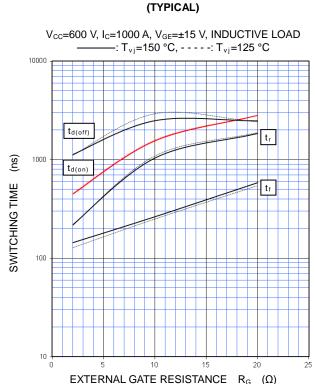
INVERTER PART

HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

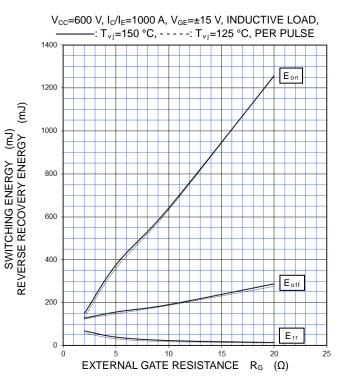


HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)





HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



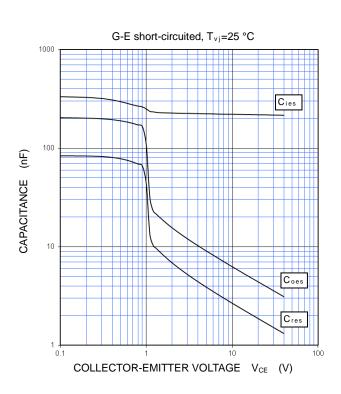
HALF-BRIDGE SWITCHING CHARACTERISTICS

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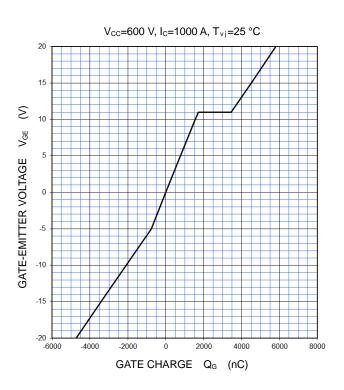
PERFORMANCE CURVES

INVERTER PART

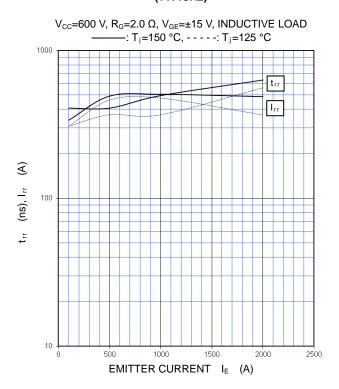
CAPACITANCE CHARACTERISTICS (TYPICAL)



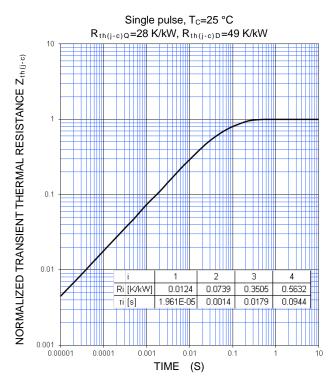
GATE CHARGE CHARACTERISTICS (TYPICAL)







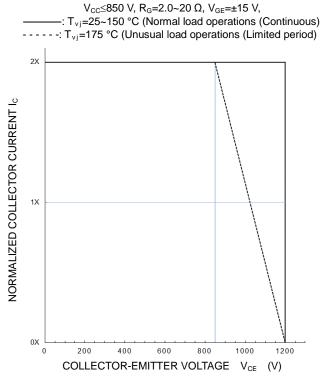
TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



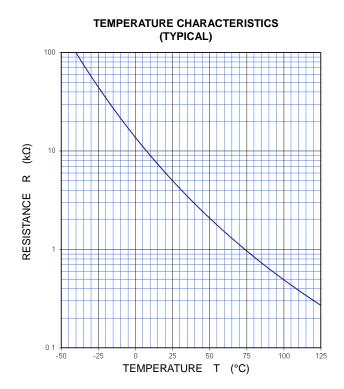
PERFORMANCE CURVES

INVERTER PART

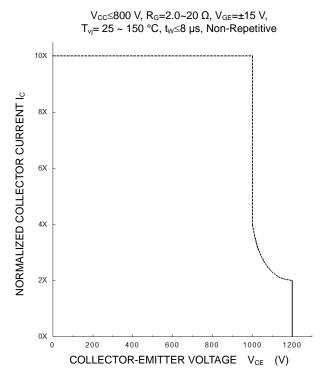
TURN-OFF SWITCHING SAFE OPERATING AREA (REVERSE BIAS SAFE OPERATING AREA) (MAXIMUM)



NTC thermistor part



SHORT-CIRCUIT SAFE OPERATING AREA (MAXIMUM)



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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